

<b>Notice of References Cited</b>	Application/Control No. 10/808,603	Applicant(s)/Patent Under Reexamination MARUTA, NAOTO	
	Examiner Paulos M. Natnael	Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,436,792 A	07-1995	Leman et al.	361/686
*	B	US-7,023,499 B2	04-2006	Williams et al.	348/836
*	C	US-6,378,830 B1	04-2002	Lu, Sheng-Nan	248/278.1
*	D	US-2004/0041851 A1	03-2004	Lu, Sheng-Nan	345/905
*	E	US-2006/0033847 A1	02-2006	Kim, Mun Hwan	348/836
*	F	US-6,570,627 B1	05-2003	Chang, Chun Soo	348/794
*	G	US-2004/0084578 A1	05-2004	Cho et al.	248/125.1
*	H	US-2006/0032998 A1	02-2006	Depay, Dean	248/291.1
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.